

"BIG IDEAS IN
BIG POWER"

PowerTech

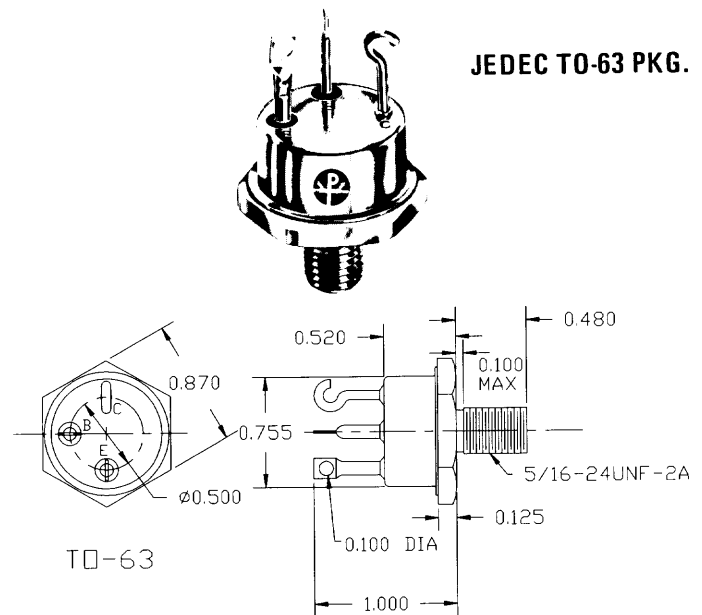
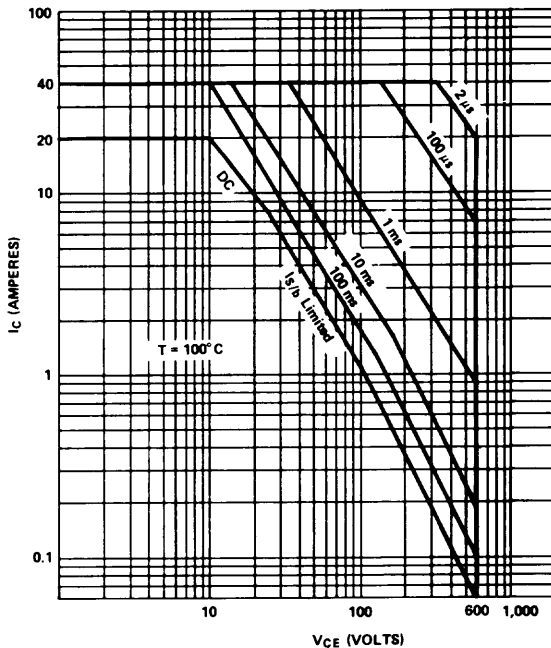
40 AMPERES

PT-3526

HIGH VOLTAGE SILICON NPN TRANSISTOR

FEATURES

$V_{CE(sat)}$	0.5V @ 20A	h_{FE}	5 min. @ 40A	I_S/B	0.06A @ 600V
V_{BE}	1.5V @ 20A	t_f	1.2 μ sec.	E_S/b	2.5 Joules



PowerTech's transistors offer high current capability, high breakdown voltage and the lowest available saturation voltage. They have exceptional resistance to both forward and reverse second breakdown. This unique combination of device characteristics makes them particularly suited for a wide variety of high current applications, which include series and switching regulators, motor controls, servoamplifiers and power control circuits. The transistors will provide outstanding performance when used as replacements for paralleled lower current devices, resulting in considerable reductions in weight, space and circuit complexity. Their reliability is assured through 100% power testing at 40V, 3A @ 100°C case temperature. These transistors exceed the requirements of MIL-S-19500 and are well suited for the most severe military-aerospace applications.

ABSOLUTE MAXIMUM RATINGS

Collector-Base Voltage
Collector-Emitter Voltage
Emitter-Base Voltage
Peak Collector Current
D. C. Collector Current
Power Dissipation at 25°C Case Temperature
Power Dissipation at 100°C Case Temperature
Operating Junction Temperature Range
Storage Temperature Range
Package:
Thermal Resistance

SYMBOL

V_{CBO}	650V
V_{CEO}	600V
V_{EBO}	10V
I_{CM}^*	40A
I_C	20A
P_D	325W
P_D	200W
T_J	-65° to 200°C
T_A	-65° to 200°C
	TO-63
θ_{JC}	0.5°C/W

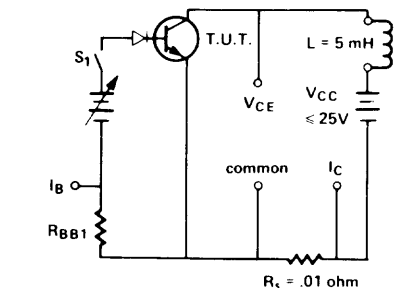
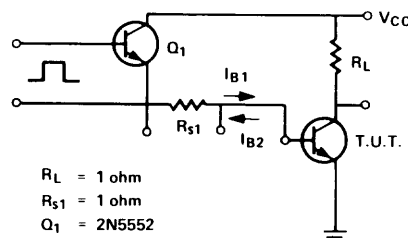
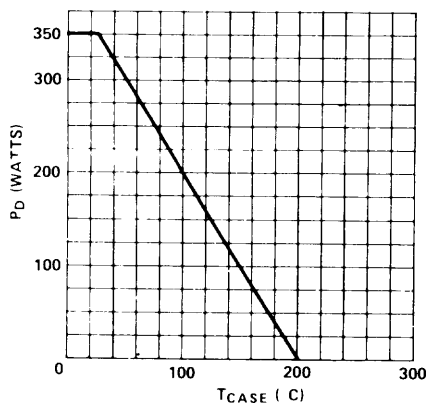
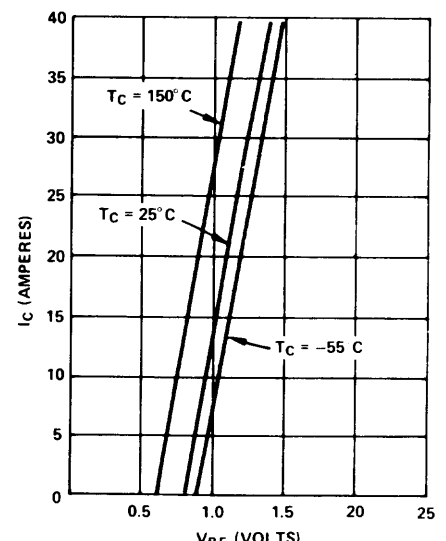
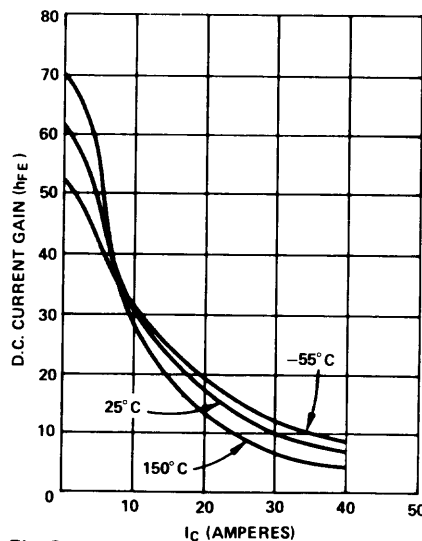
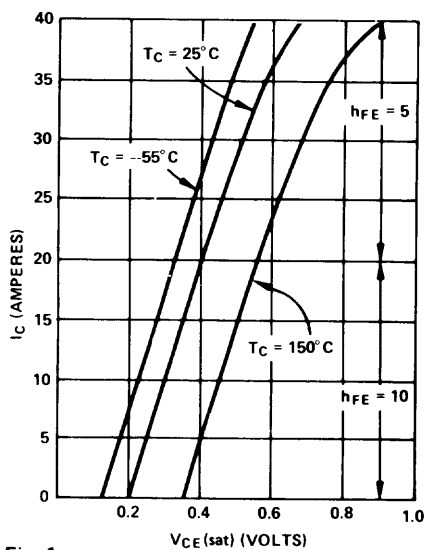
ELECTRICAL SPECIFICATIONS (at 25°C unless otherwise noted)

TEST	SYMBOL	MIN.	MAX.	UNITS	TEST CONDITIONS
D. C. Current Gain*	h_{FE}	10			$I_C=20A, V_{CE}=4V$
D. C. Current Gain*	h_{FE}	5			$I_C=40A, V_{CE}=4V$
Collector Saturation Voltage*	$V_{CE(sat)}$		0.5	V	$I_C=20A, I_B=3A$
Base Emitter Voltage*	V_{BE}		1.5	V	$I_C=20A, V_{CE}=5V$
Collector-Emitter Breakdown Voltage*	$V_{CEO(sus)}$	600		V	$I_C=50mA, I_B=0$
Collector Cutoff Current	I_{CBO}		2	mA	$V_{CB}=650V, I_{EB}=0$
Emitter Cutoff Current	I_{EBO}		5	mA	$V_{EB}=10V, I_{CB}=0$
Gain Bandwidth Product	f_t	1.5		MHz	$I_C=5A, V_{CE}=10V$
Collector Capacitance	C_{obo}		400	pF	$V_{CB}=10V$
Switching Speed (typical)	t_r		1.2	μsec	$I_C=20A$
	t_s		2.0	μsec	$I_{B1} = I_{B2} = 3A$
	t_f		1.2	μsec	

*PW $\leq 300 \mu sec$, D. C. $\leq 2\%$

ϕ V_{CE} measured with pulse 300 μsec max., $I_B = 100\mu A$

Do Not Use Curve Tracer



PROCEDURE
With S_1 closed, set $I_B = 8A$, $I_C = 35A$
Open S_1
 $E_s/b = 1/2LI^2 = 2.5$ Joules

Fig. 5. SWITCHING TEST CIRCUIT

Fig. 6. UNCLAMPED INDUCTIVE SWEEP TEST